

SECTION H — ELECTRICITY

H10 SEMICONDUCTOR DEVICES; ELECTRIC SOLID-STATE DEVICES NOT OTHERWISE PROVIDED FOR**H10F INORGANIC SEMICONDUCTOR DEVICES SENSITIVE TO INFRARED RADIATION, LIGHT, ELECTROMAGNETIC RADIATION OF SHORTER WAVELENGTH OR CORPUSCULAR RADIATION [2025.01]****Note(s) [2025.01]**

1. This subclass covers inorganic radiation-sensitive semiconductor devices insofar as these devices are specially adapted for:
 - the conversion of the radiation energy into electrical energy; or
 - the control of electrical energy by such radiation.
2. In this subclass, “infrared radiation” includes wavelengths between about 700 nm and about 1 mm.
3. In this subclass, the periodic system used is the I to VIII Group system indicated in the Periodic Table under Note (3) of section C.

Subclass index

PHOTOVOLTAICS	
Individual photovoltaic cells.....	10/00
Photovoltaic modules or integrated devices.....	19/00
RADIATION-CONTROLLED DEVICES	
Individual photoresistors, photodiodes, phototransistors or like devices.....	30/00
Integrated devices or assemblies of multiple devices.....	39/00
OTHER DEVICES	
Radiation-sensitive devices coupled to electric light sources.....	55/00
MANUFACTURE OR TREATMENT; CONSTRUCTIONAL DETAILS	
Manufacture or treatment.....	71/00
Constructional details.....	77/00
SUBJECT MATTER NOT PROVIDED FOR IN OTHER GROUPS OF THIS SUBCLASS.....	99/00

Photovoltaics [2025.01]

	10/163	• • • comprising only Group III-V materials, e.g. GaAs/AlGaAs or InP/GaInAs photovoltaic cells [2025.01]
10/00 Individual photovoltaic cells, e.g. solar cells (electrolytic light-sensitive devices, e.g. dye-sensitised solar cells, H01G 9/20) [2025.01]	10/164	• • • comprising heterojunctions with Group IV materials, e.g. ITO/Si or GaAs/SiGe photovoltaic cells [2025.01]
10/10 • having potential barriers [2025.01]		
10/11 • • Photovoltaic cells having point contact potential barriers (H10F 10/18 takes precedence) [2025.01]	10/165	• • • • the heterojunctions being Group IV-IV heterojunctions, e.g. Si/Ge, SiGe/Si or Si/SiC photovoltaic cells [2025.01]
10/12 • • Photovoltaic cells having only metal-insulator-semiconductor [MIS] potential barriers [2025.01]	10/166	• • • • the Group IV-IV heterojunctions being heterojunctions of crystalline and amorphous materials, e.g. silicon heterojunction [SHJ] photovoltaic cells [2025.01]
10/13 • • Photovoltaic cells having absorbing layers comprising graded bandgaps [2025.01]		
10/14 • • Photovoltaic cells having only PN homojunction potential barriers [2025.01]	10/167	• • • comprising Group I-III-VI materials, e.g. CdS/CuInSe ₂ [CIS] heterojunction photovoltaic cells [2025.01]
10/142 • • • comprising multiple PN homojunctions, e.g. tandem cells [2025.01]	10/17	• • Photovoltaic cells having only PIN junction potential barriers [2025.01]
10/144 • • • comprising only Group III-V materials, e.g. GaAs, AlGaAs, or InP photovoltaic cells [2025.01]	10/172	• • • comprising multiple PIN junctions, e.g. tandem cells [2025.01]
10/16 • • Photovoltaic cells having only PN heterojunction potential barriers [2025.01]	10/174	• • • comprising monocrystalline or polycrystalline materials [2025.01]
10/161 • • • comprising multiple PN heterojunctions, e.g. tandem cells [2025.01]	10/18	• • Photovoltaic cells having only Schottky potential barriers [2025.01]
10/162 • • • comprising only Group II-VI materials, e.g. CdS/CdTe photovoltaic cells [2025.01]		

H10F

- 10/19 • • Photovoltaic cells having multiple potential barriers of different types, e.g. tandem cells having both PN and PIN junctions [2025.01]
- 19/00 **Integrated devices, or assemblies of multiple devices, comprising at least one photovoltaic cell covered by group H10F 10/00, e.g. photovoltaic modules [2025.01]**
- 19/10 • comprising photovoltaic cells in arrays in a single semiconductor substrate, the photovoltaic cells having vertical junctions or V-groove junctions [2025.01]
- 19/20 • comprising photovoltaic cells in arrays in or on a single semiconductor substrate, the photovoltaic cells having planar junctions (having multiple thin-film photovoltaic cells deposited on the same substrate H10F 19/31) [2025.01]
- 19/30 • comprising thin-film photovoltaic cells [2025.01]
- 19/31 • • having multiple laterally adjacent thin-film photovoltaic cells deposited on the same substrate [2025.01]
- 19/33 • • • Patterning processes to connect the photovoltaic cells, e.g. laser cutting of conductive or active layers [2025.01]
- 19/35 • • • Structures for the connecting of adjacent photovoltaic cells, e.g. interconnections or insulating spacers [2025.01]
- 19/37 • • • comprising means for obtaining partial light transmission through the integrated devices, or the assemblies of multiple devices, e.g. partially transparent thin-film photovoltaic modules for windows [2025.01]
- 19/40 • comprising photovoltaic cells in a mechanically stacked configuration [2025.01]
- 19/50 • Integrated devices comprising at least one photovoltaic cell and other types of semiconductor or solid-state components (H10F 19/75 takes precedence) [2025.01]
- 19/70 • comprising bypass diodes (bypass diodes in a junction box H02S 40/34) [2025.01]
- 19/75 • • the bypass diodes being integrated or directly associated with the photovoltaic cells, e.g. formed in or on the same substrate [2025.01]
- 19/80 • Encapsulations or containers for integrated devices, or assemblies of multiple devices, having photovoltaic cells [2025.01]
- 19/85 • • Protective back sheets [2025.01]
- 19/90 • Structures for connecting between photovoltaic cells, e.g. interconnections or insulating spacers (between thin-film photovoltaic cells on a single substrate H10F 19/35) [2025.01]
- 30/222 • • • • the potential barrier being a PN heterojunction [2025.01]
- 30/223 • • • • the potential barrier being a PIN barrier [2025.01]
- 30/225 • • • • the potential barrier working in avalanche mode, e.g. avalanche photodiodes [2025.01]
- 30/227 • • • • the potential barrier being a Schottky barrier [2025.01]
- 30/24 • • • the devices having only two potential barriers, e.g. bipolar phototransistors [2025.01]
- 30/26 • • • the devices having three or more potential barriers, e.g. photothyristors [2025.01]
- 30/28 • • • the devices being characterised by field-effect operation, e.g. junction field-effect phototransistors [2025.01]
- 30/282 • • • • Insulated-gate field-effect transistors [IGFET], e.g. MISFET [metal-insulator-semiconductor field-effect transistor] phototransistors [2025.01]
- 30/29 • • the devices being sensitive to radiation having very short wavelengths, e.g. X-rays, gamma-rays or corpuscular radiation [2025.01]
- 30/292 • • • Bulk-effect radiation detectors, e.g. Ge-Li compensated PIN gamma-ray detectors [2025.01]
- 30/295 • • • Surface barrier or shallow PN junction radiation detectors, e.g. surface barrier alpha-particle detectors [2025.01]
- 30/298 • • • the devices being characterised by field-effect operation, e.g. MIS type detectors [2025.01]
- 39/00 **Integrated devices, or assemblies of multiple devices, comprising at least one element covered by group H10F 30/00, e.g. radiation detectors comprising photodiode arrays [2025.01]**
- 39/10 • Integrated devices [2025.01]
- 39/12 • • Image sensors [2025.01]
- 39/15 • • • Charge-coupled device [CCD] image sensors [2025.01]
- 39/18 • • • Complementary metal-oxide-semiconductor [CMOS] image sensors; Photodiode array image sensors [2025.01]
- 39/90 • Assemblies of multiple devices [2025.01]
- 39/95 • • comprising at least one integrated device covered by group H10F 39/10, e.g. comprising integrated image sensors [2025.01]

Other devices [2025.01]

Radiation-controlled devices [2025.01]

- 30/00 **Individual radiation-sensitive semiconductor devices in which radiation controls the flow of current through the devices, e.g. photodetectors [2025.01]**
- 30/10 • the devices being sensitive to infrared radiation, visible or ultraviolet radiation, and having no potential barriers, e.g. photoresistors [2025.01]
- 30/20 • the devices having potential barriers, e.g. phototransistors [2025.01]
- 30/21 • • the devices being sensitive to infrared, visible or ultraviolet radiation [2025.01]
- 30/22 • • • the devices having only one potential barrier, e.g. photodiodes [2025.01]
- 30/221 • • • • the potential barrier being a PN homojunction [2025.01]
- 55/00 **Radiation-sensitive semiconductor devices covered by groups H10F 10/00, H10F 19/00 or H10F 30/00 being structurally associated with electric light sources and electrically or optically coupled thereto [2025.01]**
- 55/10 • wherein the radiation-sensitive semiconductor devices control the electric light source, e.g. image converters, image amplifiers or image storage devices [2025.01]
- 55/15 • • wherein the radiation-sensitive devices and the electric light source are all semiconductor devices [2025.01]
- 55/155 • • • formed in, or on, a common substrate [2025.01]
- 55/20 • wherein the electric light source controls the radiation-sensitive semiconductor devices, e.g. optocouplers [2025.01]

- 55/25 • • wherein the radiation-sensitive devices and the electric light source are all semiconductor devices [2025.01]
- 55/255 • • • formed in, or on, a common substrate [2025.01]

Manufacture or treatment; Constructional details [2025.01]

- 71/00 Manufacture or treatment of devices covered by this subclass** (patterning processes to connect thin photovoltaic cells in integrated devices, or assemblies of multiple devices, having photovoltaic cells H10F 19/33; manufacture or treatment of encapsulations or containers for integrated devices, or assemblies of multiple devices, having photovoltaic cells H10F 19/80; manufacture or treatment of integrated devices, or assemblies of multiple devices, comprising at least one element in which radiation controls the flow of current H10F 39/00) [2025.01]
- 71/10 • the devices comprising amorphous semiconductor material [2025.01]
- 77/00 Constructional details of devices covered by this subclass** (constructional details of integrated devices, or assemblies of multiple devices, comprising at least one element in which radiation controls the flow of current H10F 39/00) [2025.01]

Note(s) [2025.01]

When classifying in this group, the type of device itself, when it is determined to be novel and non-obvious, should be classified in groups H10F 10/00, H10F 19/00, H10F 30/00 or H10F 55/00.

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- 77/10 • Semiconductor bodies [2025.01]
- 77/12 • • Active materials [2025.01]

Note(s) [2025.01]

When classifying in this group, constituents of a material are considered irrespective of any dopants or other impurities.

- 77/121 • • • comprising only selenium or only tellurium [2025.01]
- 77/122 • • • comprising only Group IV materials [2025.01]
- 77/1223 • • • • characterised by the dopants [2025.01]
- 77/1226 • • • • comprising multiple Group IV elements, e.g. SiC [2025.01]
- 77/123 • • • comprising only Group II-VI materials, e.g. CdS, ZnS or HgCdTe [2025.01]

- 77/124 • • • comprising only Group III-V materials, e.g. GaAs [2025.01]
- 77/14 • • Shape of semiconductor bodies; Shapes, relative sizes or dispositions of semiconductor regions within semiconductor bodies [2025.01]
- 77/16 • • Material structures, e.g. crystalline structures, film structures or crystal plane orientations [2025.01]
- 77/162 • • • Non-monocrystalline materials, e.g. semiconductor particles embedded in insulating materials (H10F 77/169 takes precedence) [2025.01]
- 77/164 • • • • Polycrystalline semiconductors [2025.01]
- 77/166 • • • • Amorphous semiconductors [2025.01]
- 77/169 • • • Thin semiconductor films on metallic or insulating substrates [2025.01]
- 77/20 • Electrodes [2025.01]
- 77/30 • Coatings (arrangements for preventing damage to photovoltaic cells caused by corpuscular radiation H10F 77/80) [2025.01]
- 77/40 • Optical elements or arrangements (surface textures H10F 77/70) [2025.01]
- 77/42 • • directly associated or integrated with photovoltaic cells, e.g. light-reflecting means or light-concentrating means [2025.01]
- 77/45 • • • Wavelength conversion means, e.g. by using luminescent material, fluorescent concentrators or up-conversion arrangements [2025.01]
- 77/48 • • • Back surface reflectors [BSR] [2025.01]
- 77/50 • Encapsulations or containers (for photovoltaic modules H10F 19/80) [2025.01]
- 77/60 • Arrangements for cooling, heating, ventilating or compensating for temperature fluctuations [2025.01]
- 77/63 • • Arrangements for cooling directly associated or integrated with photovoltaic cells, e.g. heat sinks directly associated with the photovoltaic cells or integrated Peltier elements for active cooling [2025.01]
- 77/67 • • • including means to utilise heat energy directly associated with the photovoltaic cells, e.g. integrated Seebeck elements [2025.01]
- 77/70 • Surface textures, e.g. pyramid structures [2025.01]
- 77/80 • Arrangements for preventing damage to photovoltaic cells caused by corpuscular radiation, e.g. for space applications [2025.01]
- 77/90 • Energy storage means directly associated or integrated with photovoltaic cells, e.g. capacitors integrated with photovoltaic cells [2025.01]
- 99/00 Subject matter not provided for in other groups of this subclass [2025.01]**